Docket No.: 9485.006.20-US

(PATENT)

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:

Milton Feng et al.

Application No.: Not Yet Assigned

Customer No.: 30827

Filed: March 3, 2004

Art Unit: N/A

For:

INTERGRATED PHOTODETECTOR AND

HETEROJUNCTION BIPOLAR

TRANSISTORS

Examiner: Not Yet Assigned

## **INFORMATION DISCLOSURE STATEMENT (IDS)**

MS Patent Application Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO/SB/08. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement accompanies the new continuation patent application submitted herewith. The listed references have been previously cited by the Examiner in related case Serial No. 10/379,862 filed March 4, 2003.

In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

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It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

The Director is hereby authorized to charge any deficiency in the fees filed, asserted to be filed or which should have been filed herewith (or with any paper hereafter filed in this application by this firm) to our Deposit Account No. 50-0911, under Order No. 9485.006.20-US. A duplicate copy of this paper is enclosed.

Dated: March 3, 2004

Respectfully submitted,

Song K. Jung

Registration No.: 35,210

MCKENNA LONG & ALDRIDGE LLP

1900 K Street, N.W. Washington, DC 20006

(202) 496-7500

Attorney for Applicant

PTO/SB/08a/b (08-03)
Approved for use through 07/31/2006. OMB 0651-0031
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Under the Panerwork Reduction Act of 1995, no persons are required to a

Sub	stitute for form 1449A/B/PT			Complete if Known			
				Application Number	Not Yet Assigned		
11	<b>NFORMATION</b>	1 DI	SCLOSURE	Filing Date	March 3, 2004		
l s	TATEMENT B	3Y /	APPLICANT	First Named Inventor	Milton Feng		
				Art Unit	N/A		
	(Use as many sh	eets as	necessary)	Examiner Name	Not Yet Assigned		
Sheet	1	of	2	Attorney Docket Number	9485.006.20-US		

	U.S. PATENT DOCUMENTS							
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where			
Initials*	No.1	Number-Kind Code <sup>2</sup> ( if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear			
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Examiner Initials*	Cite No.1	Foreign Patent Document  Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear				
	BA								
	BB								

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	NON PATENT LITERATURE DOCUMENTS							
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>					
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	СВ	P.A. Houston, "High Frequency Heterojunction Bipolar Transistor Devise Design and Technology," Electronics & Communication Engineering Journal, October 2000, pp. 220-228						

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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S	TATEMENT E	3Y /	APPLICANT	First Named Inventor	Milton Feng	
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	AC	US						
	AD	US						
	AE	US						
	AF	US						
	AG	US						
	AH	US		·				

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	СС	Stephen A. Campbell, "The Science and Engineering of Microelectronic Fabrication (Second Edition)," February 1, 2001, Chapter 18, pp. 465-480						

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Signature	Considered	

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